Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/823,538	CHANG, KUEN-SHAN
Examiner	Art Unit
Anh Q. Tran	2819

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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